

Probe ET3DV6

SN:1711

Manufactured:	August 7, 2002
Last calibrated:	December 16, 2003
Recalibrated:	November 21, 2005

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

DASY - Parameters of Probe: ET3DV6 SN:1711

Sensitivity in Free Space^A

Diode Compression^B

NormX	1.45 ± 10.1%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP X	95 mV
NormY	1.68 ± 10.1%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP Y	95 mV
NormZ	1.59 ± 10.1%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP Z	95 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 900 MHz Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	8.2	4.4
SAR _{be} [%]	With Correction Algorithm	0.0	0.2

TSL 1810 MHz Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	14.6	10.0
SAR _{be} [%]	With Correction Algorithm	0.6	0.1

Sensor Offset

Probe Tip to Sensor Center **2.7 mm**

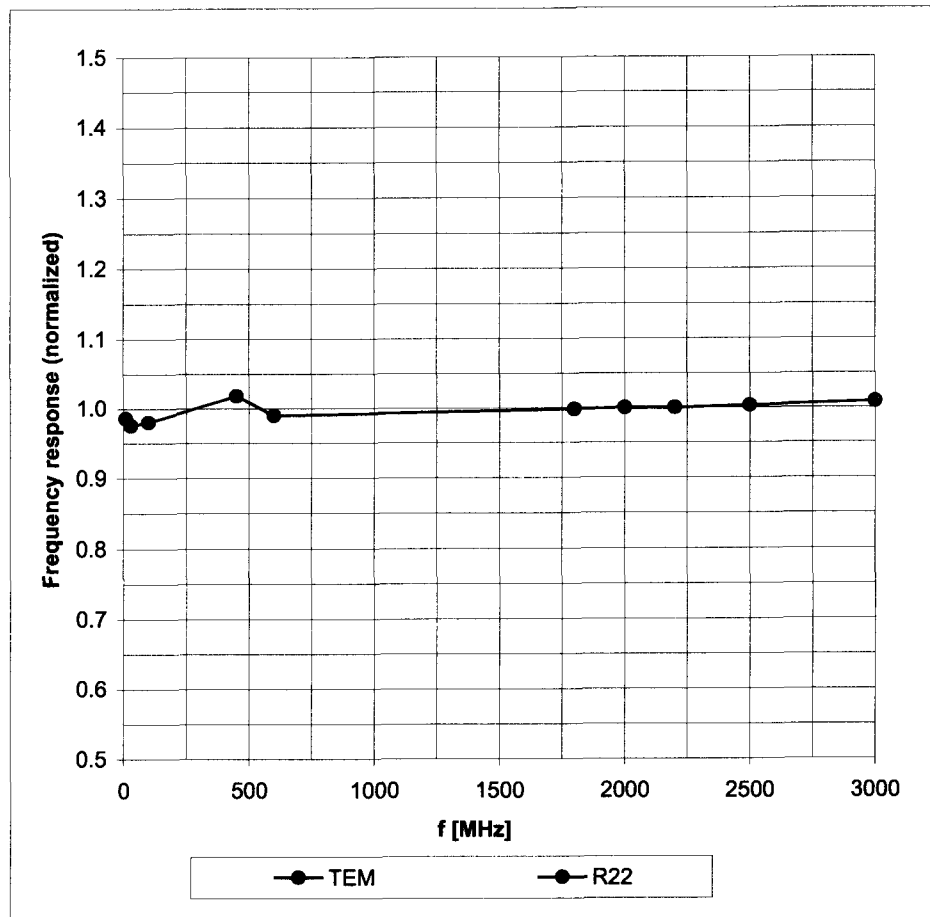
The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 8).

^B Numerical linearization parameter: uncertainty not required.

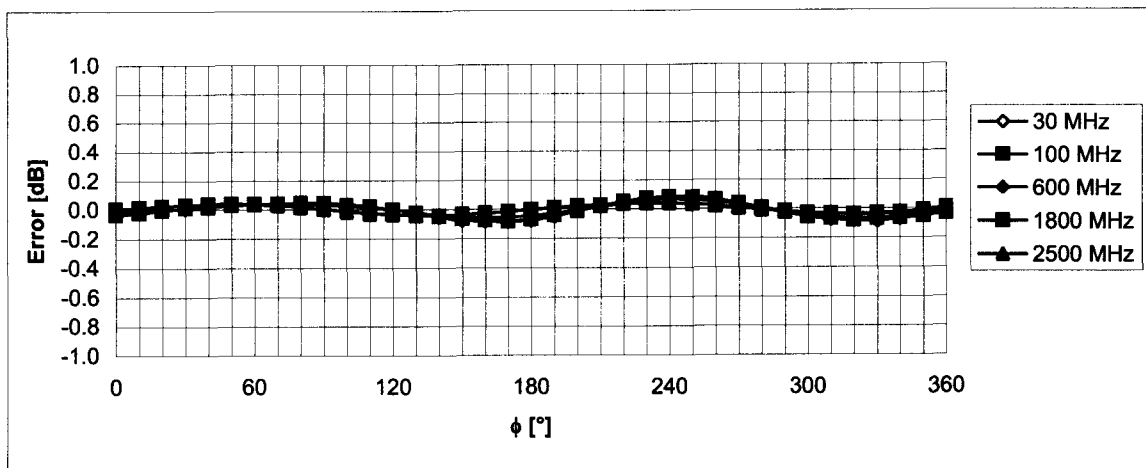
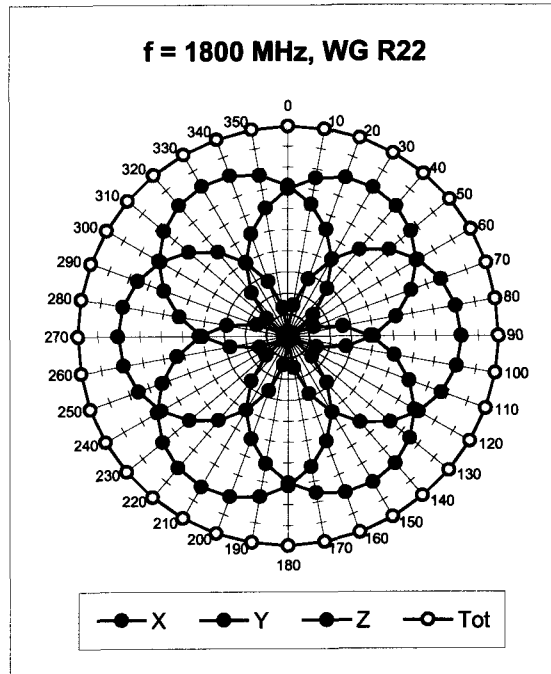
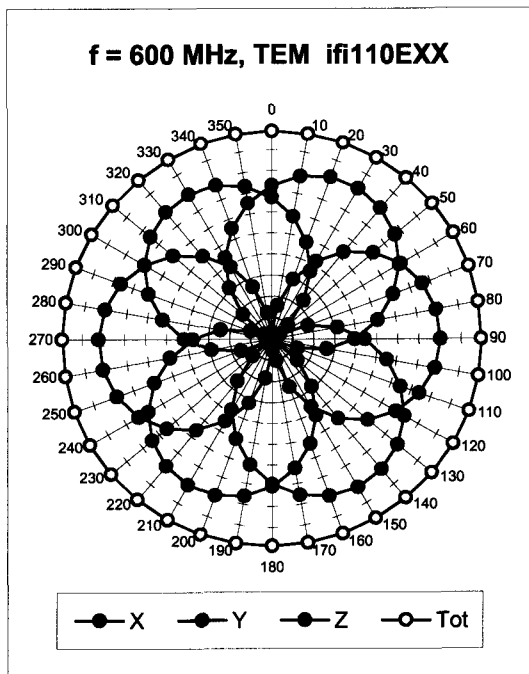
Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



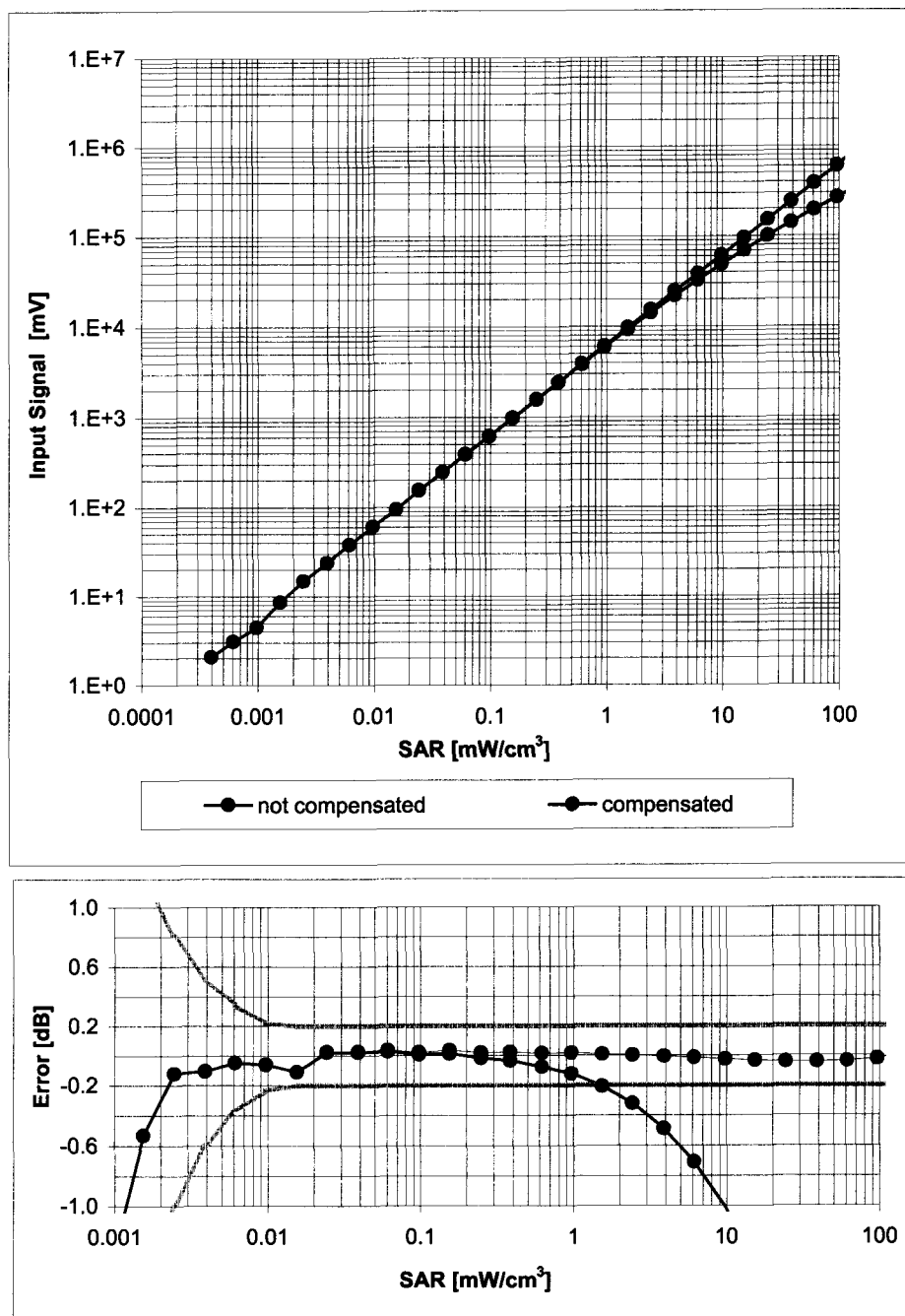
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

Receiving Pattern (ϕ), $\vartheta = 0^\circ$



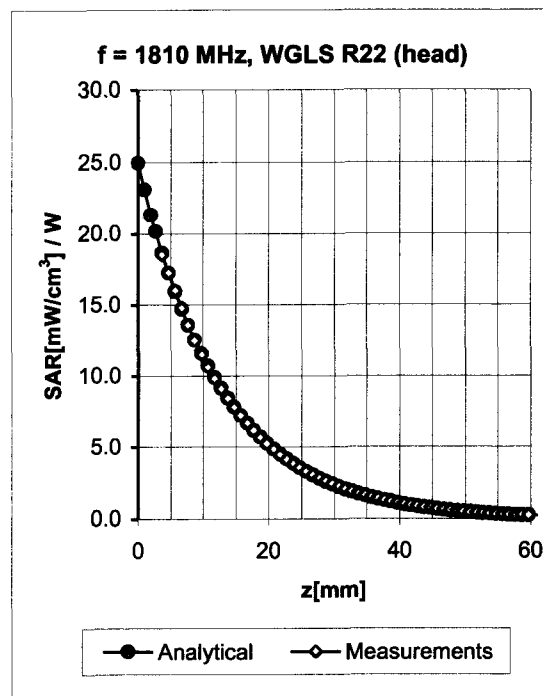
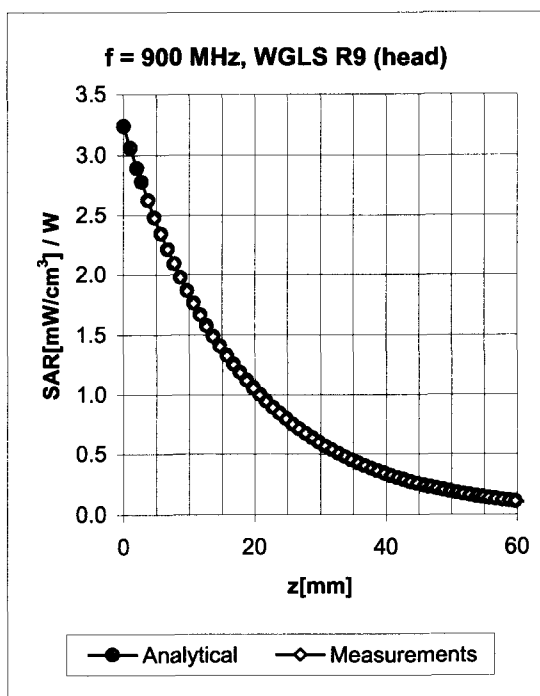
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

Dynamic Range $f(\text{SAR}_{\text{head}})$ (Waveguide R22, $f = 1800 \text{ MHz}$)



Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

Conversion Factor Assessment

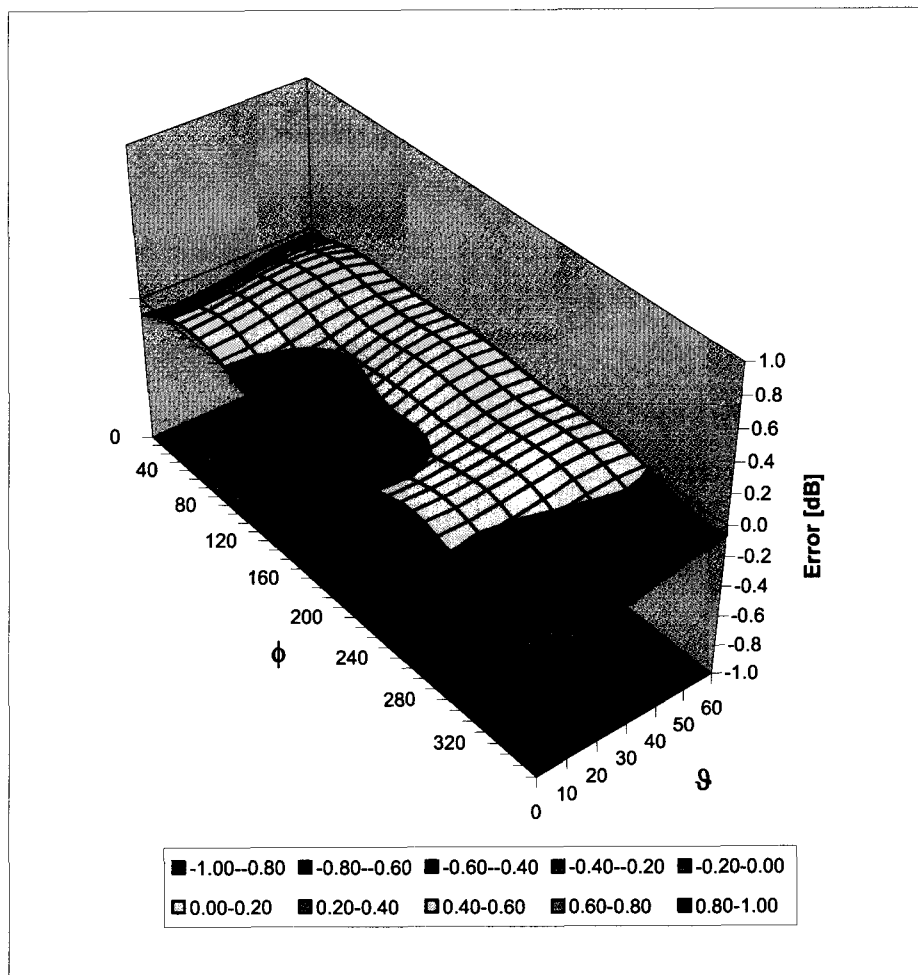


f [MHz]	Validity [MHz] ^c	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
450	± 50 / ± 100	Head	43.5 ± 5%	0.87 ± 5%	0.02	2.48	6.52 ± 13.3% (k=2)
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	0.55	1.87	5.99 ± 11.0% (k=2)
1810	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.57	2.55	4.84 ± 11.0% (k=2)
1950	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.56	2.59	4.54 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.70	2.28	4.27 ± 11.8% (k=2)
450	± 50 / ± 100	Body	56.7 ± 5%	0.94 ± 5%	0.02	2.36	6.96 ± 13.3% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.49	2.11	5.73 ± 11.0% (k=2)
1810	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.56	2.77	4.31 ± 11.0% (k=2)
1950	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.57	2.61	4.13 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.79	1.67	4.11 ± 11.8% (k=2)

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Deviation from Isotropy in HSL

Error (ϕ , ϑ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)

IMPORTANT NOTICE

USAGE OF PROBES IN ORGANIC SOLVENTS

Diethylene Glycol Monobutyl Ether (the basis for liquids above 1 GHz), as many other organic solvents, is a very effective softener for synthetic materials. These solvents can cause irreparable damage to certain SPEAG products, except those which are explicitly declared as compliant with organic solvents.

Compatible Probes:

- ET3DV6
- ET3DV6R
- ES3DVx
- EX3DVx
- ER3DV6
- H3DV6

Important Note for ET3DV6 Probes:

The ET3DV6 probes shall not be exposed to solvents longer than necessary for the measurements and shall be cleaned daily after use with warm water and stored dry.

s p e a g

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Schmid & Partner Engineering AG

Additional Conversion Factors

for Dosimetric E-Field Probe

Type:

ET3DV6

Serial Number:

1711

Place of Assessment:

Zurich

Date of Assessment:

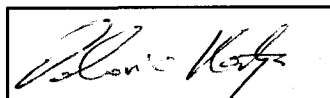
November 23, 2005

Probe Calibration Date:

November 21, 2005

Schmid & Partner Engineering AG hereby certifies that conversion factor(s) of this probe have been evaluated on the date indicated above. The assessment was performed using the FDTD numerical code SEMCAD of Schmid & Partner Engineering AG. The evaluation is coupled with measured conversion factors (probe calibration date indicated above). The uncertainty of the numerical assessment is based on the extrapolation from measured value at 900 MHz or at 1810 MHz.

Assessed by:



Dosimetric E-Field Probe ET3DV6 SN:1711Conversion factor ($\pm$ standard deviation)**150 $\pm$ 50 MHz** *ConvF* **8.1 $\pm$ 10 %**

$\epsilon_r = 52.3 \pm 5\%$
 $\sigma = 0.76 \pm 5\%$ mho/m
(head tissue)

150 $\pm$ 50 MHz *ConvF* **7.8 $\pm$ 10 %**

$\epsilon_r = 61.9 \pm 5\%$
 $\sigma = 0.80 \pm 5\%$ mho/m
(body tissue)

300 $\pm$ 50 MHz *ConvF* **7.3 $\pm$ 9 %**

$\epsilon_r = 45.3 \pm 5\%$
 $\sigma = 0.87 \pm 5\%$ mho/m
(head tissue)

Important Note:

For numerically assessed probe conversion factors, parameters Alpha and Delta in the DASY software must have the following entries: Alpha = 0 and Delta = 1.

Please see also Section 4.7 of the DASY4 Manual.



Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **ETS Dr. Genz**

Certificate No: **DAE3-522_Nov05**

CALIBRATION CERTIFICATE

Object **DAE3 - SD 000 D03 AA - SN: 522**

Calibration procedure(s) **QA CAL-06.v12**
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: **November 23, 2005**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	7-Oct-05 (Sintrel, No.E-050073)	Oct-06
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1002	29-Jun-05 (SPEAG, in house check)	In house check Jun-06

Calibrated by: Name **Eric Hainfeld** Function **Technician** Signature 

Approved by: **Fin Bornholt** R&D Director 

Issued: November 23, 2005

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.



Glossary

DAE	data acquisition electronics
Connector angle	information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters contain technical information as a result from the performance test and require no uncertainty.
- **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
- **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
- **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
- **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
- **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
- **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
- **Input resistance:** DAE input resistance at the connector, during internal auto-zeroing and during measurement.
- **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
- **Power consumption:** Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V , full range = -100...+300 mV

Low Range: 1LSB = 61 nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.289 $\pm$ 0.1% (k=2)	403.958 $\pm$ 0.1% (k=2)	404.788 $\pm$ 0.1% (k=2)
Low Range	3.95603 $\pm$ 0.7% (k=2)	3.93852 $\pm$ 0.7% (k=2)	3.96295 $\pm$ 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	60 ° $\pm$ 1 °
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Appendix

1. DC Voltage Linearity

High Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	200000	199999.5	0.00
Channel X	+ Input	20000	20004.13	0.02
Channel X	- Input	20000	-19999.46	0.00
Channel Y	+ Input	200000	200000.3	0.00
Channel Y	+ Input	20000	20003.71	0.02
Channel Y	- Input	20000	-20000.98	0.00
Channel Z	+ Input	200000	199999.5	0.00
Channel Z	+ Input	20000	20001.35	0.01
Channel Z	- Input	20000	-20001.38	0.01

Low Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	2000	2000	0.00
Channel X	+ Input	200	200.74	0.37
Channel X	- Input	200	-200.66	0.33
Channel Y	+ Input	2000	2000	0.00
Channel Y	+ Input	200	199.67	-0.17
Channel Y	- Input	200	-200.19	0.09
Channel Z	+ Input	2000	2000.1	0.00
Channel Z	+ Input	200	199.46	-0.27
Channel Z	- Input	200	-200.78	0.39

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	-4.69	-5.13
	- 200	5.48	5.55
Channel Y	200	-0.70	-0.94
	- 200	0.03	0.01
Channel Z	200	16.03	15.52
	- 200	-17.34	-18.11

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	2.29	0.70
Channel Y	200	1.28	-	2.45
Channel Z	200	-2.82	-0.11	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15727	15989
Channel Y	15754	16141
Channel Z	16032	16721

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.86	-1.08	2.33	0.61
Channel Y	-1.73	-3.15	0.41	0.60
Channel Z	-1.20	-2.72	0.46	0.55

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2000	199.2
Channel Y	0.2000	200.1
Channel Z	0.2001	197.2

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9

IMPORTANT NOTICE

USAGE OF THE DAE 3

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE3 unit is connected to a fragile 3-pin battery connector. Customer is responsible to apply utmost caution not to bend or damage the connector when changing batteries.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration Customer shall remove the batteries and pack the DAE in an antistatic bag. The packaging shall protect the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, Customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.